

Search Notes

Application/Control No.

10/617,532

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
360	235.4	9/12/2006	TJ

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east Report	9/12/2006	TJ